

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10582694	BAYER ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Aaron R Eastman	3745

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
416	215, 214A, 214R, 220R, 221, 248	03/17/2011	ARE
29	889.21	03/18/2011	ARE
416	219R, 220A, 219A, 204A	03/18/2011	ARE
Update	Above	10/18/2011	ARE

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Ninh Nguyen	03/17/2011	ARE
Richard Edgar	03/18/2011	ARE
Nathan Wiehe	03/18/2011	ARE
Nathan Wiehe	10/06/2011	ARE
Nathan Wiehe	10/18/2011	ARE

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
All	Above	10/18/2011	ARE

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